

JC10 Rec'd PCT/PTO 07 NOV 2005

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Attorney's Docket No.: 07977-213002 / US3521/3522D1

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Ohtani, et al.
Serial No. : 09/455,991 ✓
Filed : December 6, 1999

Art Unit : 2815
Examiner : Jose R. Diaz
Confirmation No.: 5835

Notice of Allowance Date: October 3, 2005

Title : METHOD OF MANUFACTURING A SEMICONDUCTOR DEVICE HAVING
TFTS WITH UNIFORM CHARACTERISTICS (AS AMENDED)

MAIL STOP ISSUE FEE

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

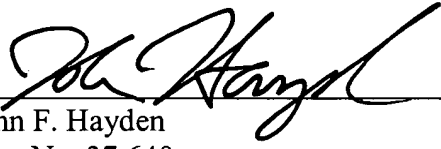
REQUEST FOR INITIALED PTO FORM 1449

Upon reviewing the file, applicants noted that they have not received an initialed copy of the enclosed PTO Form 892 that accompanied the application filed December 6, 1999.

Applicants' records show that the submission of this document complied with 37 CFR 1.97. For the Examiner's convenience, U.S. Patent Nos. 5,818,068 and 5,814,835, which were identified on the PTO Form 892, have been submitted on the enclosed PTO Form 1449.

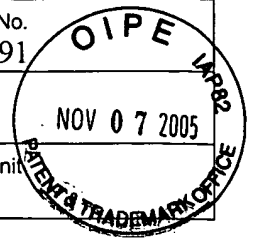
Thus, it is respectfully requested that the Examiner initial and return the PTO-1449 as soon as possible. As the applicants must pay the issue fee by **January 3, 2006**, the Examiner's prompt attention to this matter would be appreciated.

Respectfully submitted,

Date: 11/7/05
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Substitute Form PTO-1449 (Modified) Information Disclosure Statement by Applicant (Use several sheets if necessary) (37 CFR §1.98(b))	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 07977-213002	Application No. 09/455,991
	Applicant Ohtani, et al.		
	Filing Date December 6, 1999	Group Art Unit 2815	

**U.S. Patent Documents**

Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA	5,818,068	10/06/1998	Sasaki et al.			
	AB	5,814,835	09/29/1998	Makita et al.			
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

Foreign Patent Documents or Published Foreign Patent Applications

Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
	AL							
	AM							
	AN							
	AO							
	AP							

Other Documents (include Author, Title, Date, and Place of Publication)

Examiner Initial	Desig. ID	Document
	AQ	
	AR	
	AS	
	AT	

Examiner Signature	Date Considered
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	